



**ALPHA & OMEGA**  
SEMICONDUCTOR

# AO4706

## 30V N-Channel MOSFET

### SRFET™

#### General Description

**SRFET™** The AO4706 uses advanced trench technology with a monolithically integrated Schottky diode to provide excellent  $R_{DS(ON)}$  and low gate charge. This device is suitable for use as a low side FET in SMPS, load switching and general purpose applications.

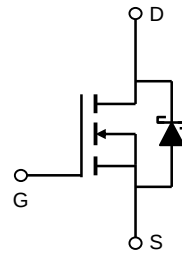
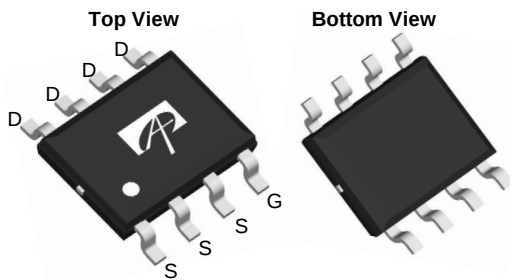
#### Product Summary

$V_{DS}$  (V) = 30V  
 $I_D = 16.5A$  ( $V_{GS} = 10V$ )  
 $R_{DS(ON)} < 6.8m\Omega$  ( $V_{GS} = 10V$ )  
 $R_{DS(ON)} < 8.2m\Omega$  ( $V_{GS} = 4.5V$ )

100% UIS Tested  
 100% Rg Tested



SOIC-8



**SRFET™**  
 Soft Recovery MOSFET:  
 Integrated Schottky Diode

#### Absolute Maximum Ratings $T_A = 25^\circ C$ unless otherwise noted

| Parameter                                            | Symbol             | Maximum    | Units      |
|------------------------------------------------------|--------------------|------------|------------|
| Drain-Source Voltage                                 | $V_{DS}$           | 30         | V          |
| Gate-Source Voltage                                  | $V_{GS}$           | $\pm 12$   | V          |
| Continuous Drain Current <sup>AF</sup>               | $T_A = 25^\circ C$ | 16.5       | A          |
|                                                      | $T_A = 70^\circ C$ | 13.2       |            |
| Pulsed Drain Current <sup>B</sup>                    | $I_{DM}$           | 100        | A          |
| Avalanche Current <sup>B</sup>                       | $I_{AR}$           | 30         | A          |
| Repetitive avalanche energy $L = 0.3mH$ <sup>B</sup> | $E_{AR}$           | 135        | mJ         |
| Power Dissipation                                    | $T_A = 25^\circ C$ | 3.1        | W          |
|                                                      | $T_A = 70^\circ C$ | 2.0        |            |
| Junction and Storage Temperature Range               | $T_J, T_{STG}$     | -55 to 150 | $^\circ C$ |

#### Thermal Characteristics

| Parameter                                |              | Symbol          | Typ | Max | Units        |
|------------------------------------------|--------------|-----------------|-----|-----|--------------|
| Maximum Junction-to-Ambient <sup>A</sup> | $t \leq 10s$ | $R_{\theta JA}$ | 31  | 40  | $^\circ C/W$ |
| Maximum Junction-to-Ambient <sup>A</sup> | Steady-State |                 | 59  | 75  | $^\circ C/W$ |
| Maximum Junction-to-Lead <sup>C</sup>    | Steady-State | $R_{\theta JL}$ | 16  | 24  | $^\circ C/W$ |

Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)

| Symbol                      | Parameter                                        | Conditions                                                                                | Min | Typ        | Max         | Units |
|-----------------------------|--------------------------------------------------|-------------------------------------------------------------------------------------------|-----|------------|-------------|-------|
| <b>STATIC PARAMETERS</b>    |                                                  |                                                                                           |     |            |             |       |
| BV <sub>DSS</sub>           | Drain-Source Breakdown Voltage                   | I <sub>D</sub> =1mA, V <sub>GS</sub> =0V                                                  | 30  |            |             | V     |
| I <sub>DSS</sub>            | Zero Gate Voltage Drain Current                  | V <sub>DS</sub> =30V, V <sub>GS</sub> =0V<br>T <sub>J</sub> =125°C                        |     | 0.02<br>10 | 0.1<br>20   | mA    |
| I <sub>GSS</sub>            | Gate-Body leakage current                        | V <sub>DS</sub> =0V, V <sub>GS</sub> = ±12V                                               |     |            | 0.1         | μA    |
| V <sub>GS(th)</sub>         | Gate Threshold Voltage                           | V <sub>DS</sub> =V <sub>GS</sub> I <sub>D</sub> =250μA                                    | 1.5 | 1.85       | 2.4         | V     |
| I <sub>D(ON)</sub>          | On state drain current                           | V <sub>GS</sub> =10V, V <sub>DS</sub> =5V                                                 | 100 |            |             | A     |
| R <sub>DS(ON)</sub>         | Static Drain-Source On-Resistance                | V <sub>GS</sub> =10V, I <sub>D</sub> =16.5A<br>T <sub>J</sub> =125°C                      |     | 5.6<br>8.4 | 6.8<br>10.5 | mΩ    |
|                             |                                                  | V <sub>GS</sub> =4.5V, I <sub>D</sub> =15A                                                |     | 6.8        | 8.2         | mΩ    |
|                             |                                                  |                                                                                           |     |            |             |       |
| g <sub>FS</sub>             | Forward Transconductance                         | V <sub>DS</sub> =5V, I <sub>D</sub> =16.5A                                                |     | 112        |             | S     |
| V <sub>SD</sub>             | Diode Forward Voltage                            | I <sub>S</sub> =1A, V <sub>GS</sub> =0V                                                   |     | 0.37       | 0.5         | V     |
| I <sub>S</sub>              | Maximum Body-Diode + Schottky Continuous Current |                                                                                           |     |            | 5           | A     |
| <b>DYNAMIC PARAMETERS</b>   |                                                  |                                                                                           |     |            |             |       |
| C <sub>iss</sub>            | Input Capacitance                                | V <sub>GS</sub> =0V, V <sub>DS</sub> =15V, f=1MHz                                         |     | 4000       | 5000        | pF    |
| C <sub>oss</sub>            | Output Capacitance                               |                                                                                           |     | 520        |             | pF    |
| C <sub>rss</sub>            | Reverse Transfer Capacitance                     |                                                                                           |     | 217        |             | pF    |
| R <sub>g</sub>              | Gate resistance                                  | V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz                                          |     | 0.6        | 0.9         | Ω     |
| <b>SWITCHING PARAMETERS</b> |                                                  |                                                                                           |     |            |             |       |
| Q <sub>g</sub> (10V)        | Total Gate Charge                                | V <sub>GS</sub> =10V, V <sub>DS</sub> =15V, I <sub>D</sub> =17A                           |     | 59         | 77          | nC    |
| Q <sub>g</sub> (4.5V)       | Total Gate Charge                                |                                                                                           |     | 27         | 35          | nC    |
| Q <sub>gs</sub>             | Gate Source Charge                               |                                                                                           |     | 12         |             | nC    |
| Q <sub>gd</sub>             | Gate Drain Charge                                |                                                                                           |     | 11         |             | nC    |
| t <sub>D(on)</sub>          | Turn-On DelayTime                                | V <sub>GS</sub> =10V, V <sub>DS</sub> =15V, R <sub>L</sub> =0.9Ω,<br>R <sub>GEN</sub> =3Ω |     | 9          |             | ns    |
| t <sub>r</sub>              | Turn-On Rise Time                                |                                                                                           |     | 9          |             | ns    |
| t <sub>D(off)</sub>         | Turn-Off DelayTime                               |                                                                                           |     | 37         |             | ns    |
| t <sub>f</sub>              | Turn-Off Fall Time                               |                                                                                           |     | 8          |             | ns    |
| t <sub>rr</sub>             | Body Diode Reverse Recovery Time                 | I <sub>F</sub> =16.5A, dI/dt=300A/μs                                                      |     | 17         | 20          | ns    |
| Q <sub>rr</sub>             | Body Diode Reverse Recovery Charge               | I <sub>F</sub> =16.5A, dI/dt=300A/μs                                                      |     | 21         |             | nC    |

A: The value of R<sub>θJA</sub> is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25°C. The value in any given application depends on the user's specific board design.

B: Repetitive rating, pulse width limited by junction temperature T<sub>J(MAX)</sub>=150°C.

C: The R<sub>θJA</sub> is the sum of the thermal impedance from junction to lead R<sub>θJL</sub> and lead to ambient.

D: The static characteristics in Figures 1 to 6 are obtained using <300 us pulses, duty cycle 0.5% max.

E: These tests are performed with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25°C. The SOA curve provides a single pulse rating.

F: The current rating is based on the t ≤ 10s thermal resistance rating.

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## TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

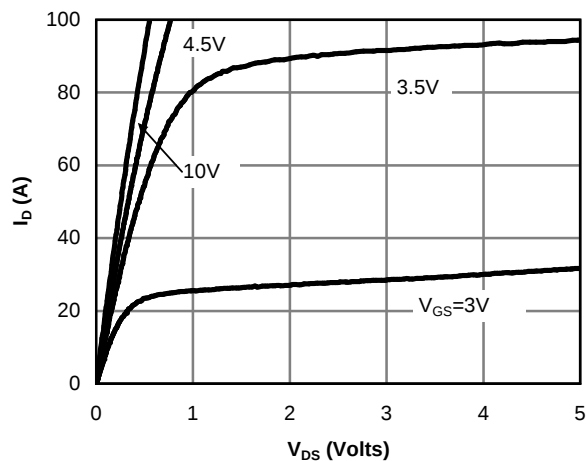


Figure 1: On-Region Characteristics

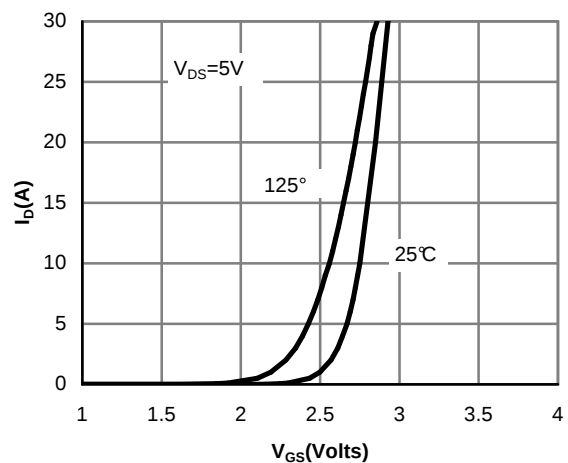


Figure 2: Transfer Characteristics

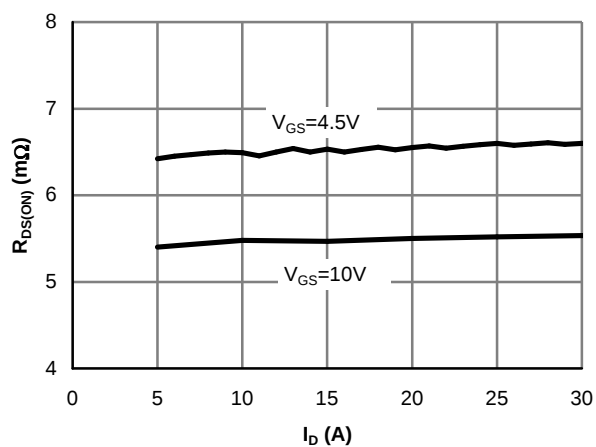


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

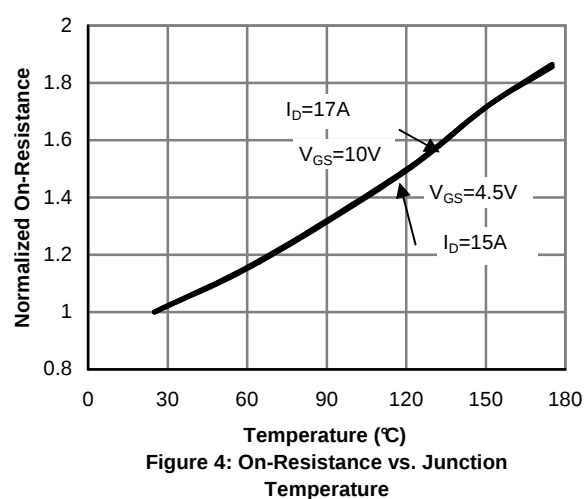


Figure 4: On-Resistance vs. Junction Temperature

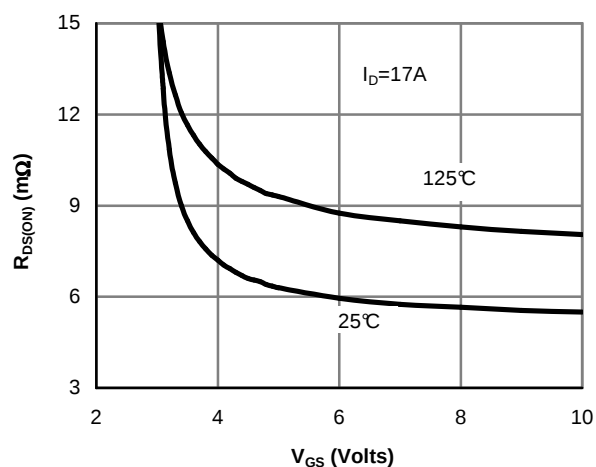


Figure 5: On-Resistance vs. Gate-Source Voltage

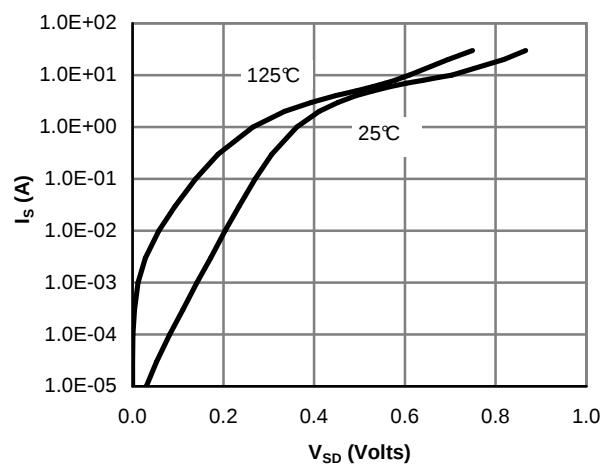


Figure 6: Body-Diode Characteristics

## TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

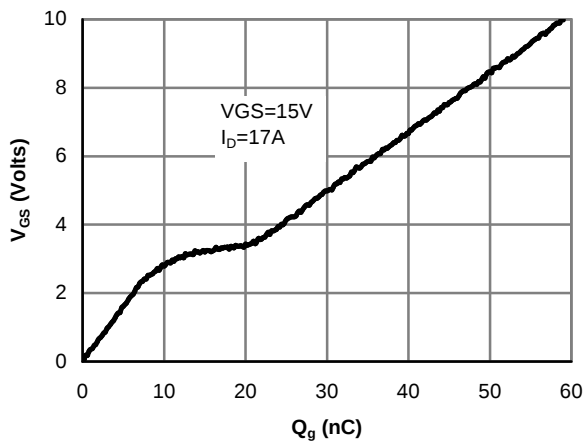


Figure 7: Gate-Charge Characteristics

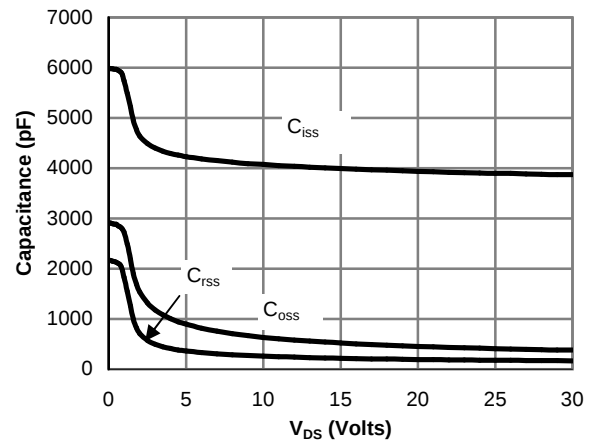


Figure 8: Capacitance Characteristics

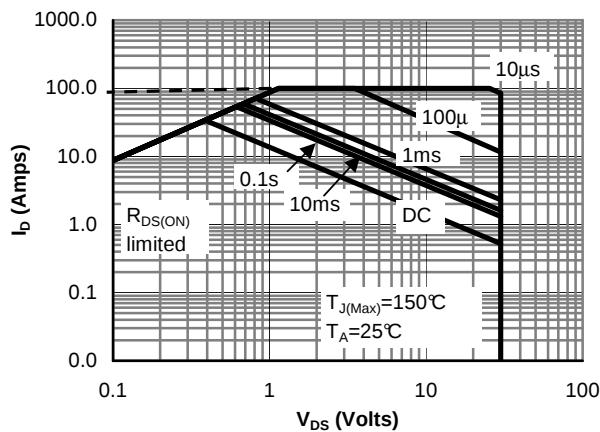


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

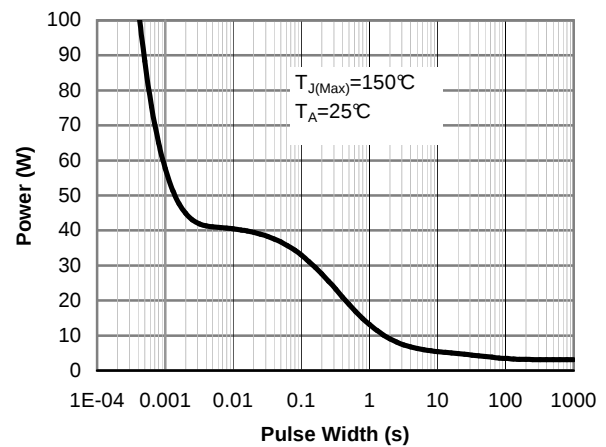


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

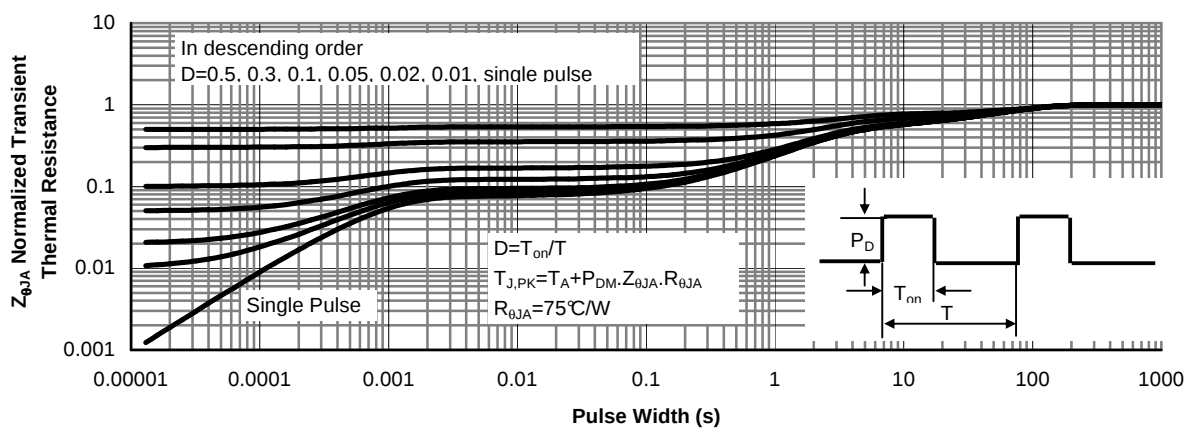


Figure 11: Normalized Maximum Transient Thermal Impedance (Note E)

## TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

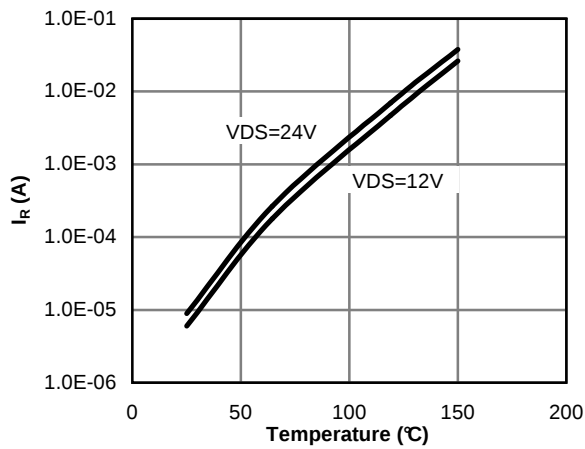


Figure 12: Diode Reverse Leakage Current vs. Junction Temperature

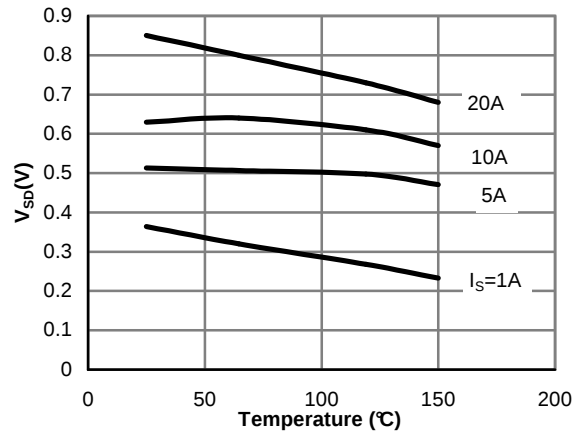


Figure 13: Diode Forward voltage vs. Junction Temperature

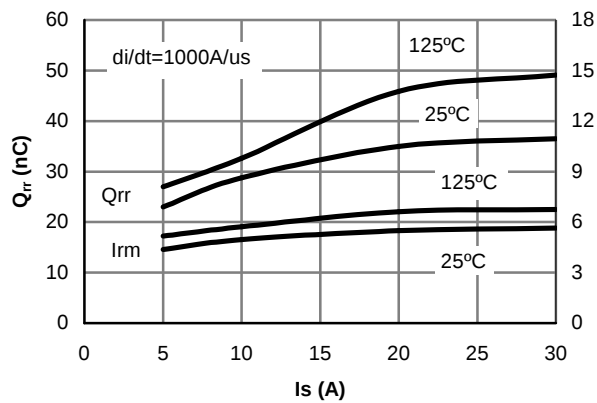


Figure 14: Diode Reverse Recovery Charge and Peak Current vs. Conduction Current

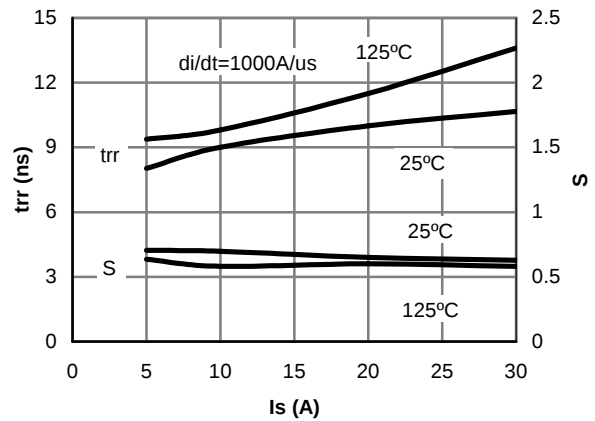


Figure 15: Diode Reverse Recovery Time and Soft Coefficient vs. Conduction Current

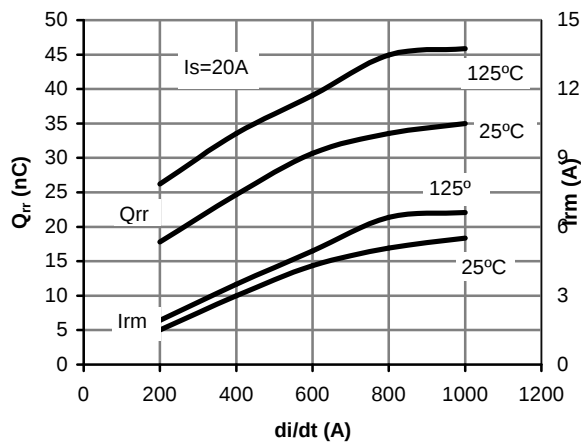


Figure 16: Diode Reverse Recovery Charge and Peak Current vs. di/dt

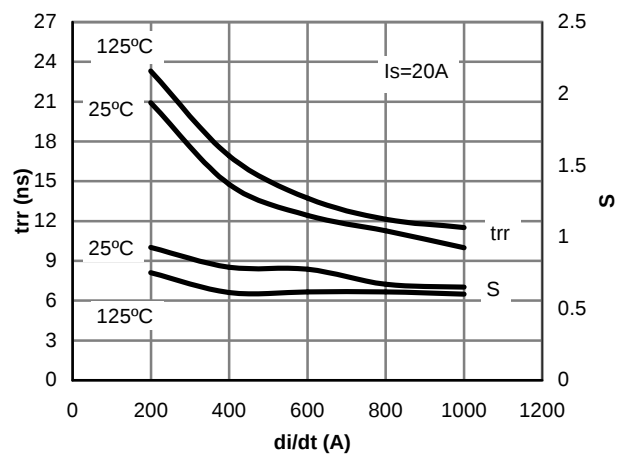
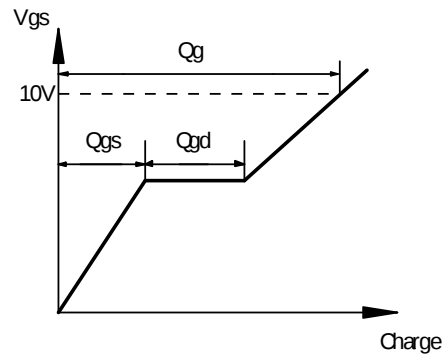
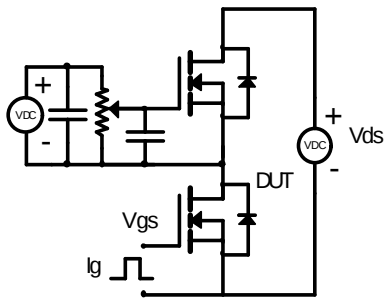
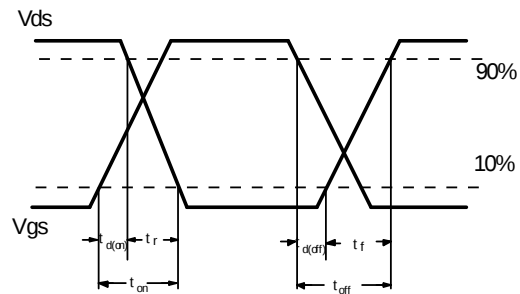
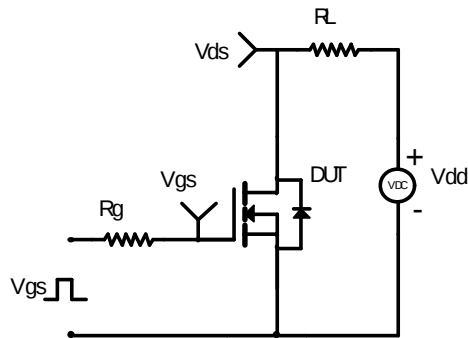


Figure 17: Diode Reverse Recovery Time and Soft Coefficient vs. di/dt

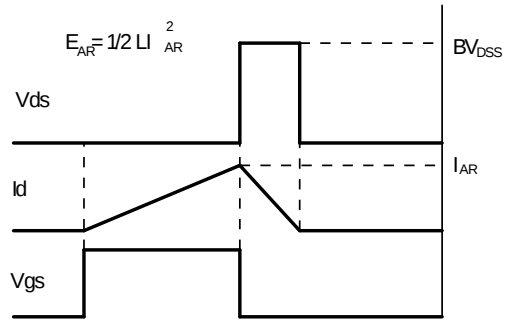
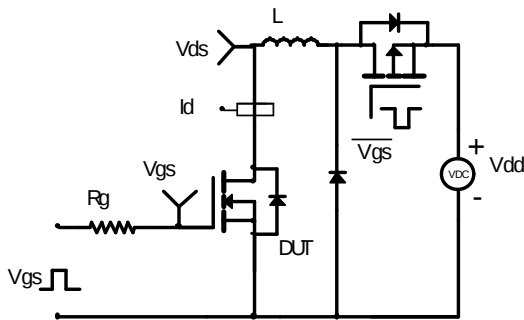
Gate Charge Test Circuit &amp; Waveform



Resistive Switching Test Circuit &amp; Waveforms



Unclamped Inductive Switching (UIS) Test Circuit &amp; Waveforms



Diode Recovery Test Circuit &amp; Waveforms

